the Fibonacci recurrence. Define the generating function (or formal power se-

$$\mathcal{F}(z) = \sum_{i=0}^{\infty} F_i z^i$$

= 0 + z + z^2 + 2z^3 + 3z^4 + 5z^5 + 8z^6 + 13z^7 + 21z^8 + \cdots,

where F_i is the *i*th Fibonacci number.

- a. Show that $\mathcal{F}(z) = z + z\mathcal{F}(z) + z^2\mathcal{F}(z)$.
- b. Show that

Show that
$$\mathcal{F}(z) = \frac{z}{1 - z - z^2}$$

$$= \frac{z}{(1 - \phi z)(1 - \widehat{\phi}z)}$$

$$= \frac{1}{\sqrt{5}} \left(\frac{1}{1 - \phi z} - \frac{1}{1 - \widehat{\phi}z} \right),$$

where

$$\phi = \frac{1 + \sqrt{5}}{2} = 1.61803\dots$$

$$\widehat{\phi} = \frac{1 - \sqrt{5}}{2} = -0.61803\dots$$

$$\mathcal{F}(z) = \sum_{i=0}^{\infty} \frac{1}{\sqrt{5}} (\phi^i - \widehat{\phi}^i) z^i.$$

- **d.** Prove that $F_i = \phi^i/\sqrt{5}$ for i > 0, rounded to the nearest integer. (*Hint:* Observe that $|\hat{\phi}| < 1$.)
- e. Prove that $F_{i+2} \ge \phi^i$ for $i \ge 0$.

4-6 VLSI chip testing

Professor Diogenes has n supposedly identical VLSI¹ chips that in principle are capable of testing each other. The professor's test jig accommodates two chips at

¹VLSI stands for "very large scale integration," which is the integrated-circuit chip technology used to fabricate most microprocessors today.